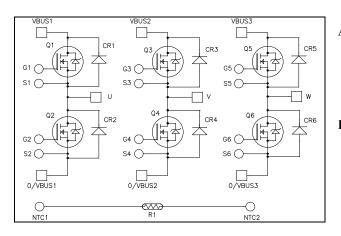
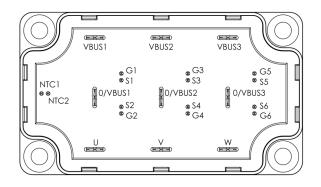


## Triple phase leg SiC MOSFET Power Module





## $V_{DSS} = 1200V$ $R_{DSon} = 17m\Omega \text{ max} @ \text{Tj} = 25^{\circ}\text{C}$ $I_D = 147\text{A} @ \text{Tc} = 25^{\circ}\text{C}$

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss

#### SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

### All ratings @ T<sub>j</sub> = 25°C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Voltage		1200	V
т	Continuous Drain Current	$T_c = 25^{\circ}C$	147	
I <sub>D</sub>		$T_c = 80^{\circ}C$	110	Α
I <sub>DM</sub>	Pulsed Drain current		300	
V <sub>GS</sub>	Gate - Source Voltage		-10/25V	V
R <sub>DSon</sub>	Drain - Source ON Resistance		17	mΩ
P <sub>D</sub>	Maximum Power Dissipation	$T_c = 25^{\circ}C$	625	W

### Electrical Characteristics (per SiC MOSFET)

Symbol	<i>Characteristic</i>	Test Conditions		Min	Тур	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 1200V$				200	μA
р	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		12.5	17	
R <sub>DS(on)</sub>		$I_{\rm D} = 100 {\rm A}$	$T_{i} = 150^{\circ}C$		22	32	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 20 \text{mA}$		2.1	2.4		V
I <sub>GSS</sub>	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.2	μA

### **Dynamic Characteristics** (per SiC MOSFET)

Symbol	<i>Characteristic</i>	Test Conditions		Min	Тур	Max	Unit
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$	$V_{GS} = 0V$ $V_{DS} = 1000V$		5.6		
C <sub>oss</sub>	Output Capacitance	$V_{\rm DS} = 1000 V$			0.44		nF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz			0.03		
Qg	Total gate Charge	$V_{GS} = -5/+20V$			322		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 800V$			92		nC
Q <sub>gd</sub>	Gate – Drain Charge	$I_{\rm D} = 100 {\rm A}$			100		
T <sub>d(on)</sub>	Turn-on Delay Time	$V_{-} = 5/+20V_{-}$			35		
Tr	Rise Time	$V_{\rm Bus} = 800V$	$V_{GS} = -5/+20V V_{Bus} = 800V I_D = 100A, T_J = 150^{\circ}C R_L = 8\Omega; R_{Gext} = 10\Omega$		40		
T <sub>d(off)</sub>	Turn-off Delay Time				150		ns
$T_{f}$	Fall Time	$R_L = 8\Omega$ ; $R_{Gext} = 108$			70		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150^{\circ}C$		2.2		mJ
E <sub>off</sub>	Turn off Energy	$I_{\rm D} = 100 \text{A}$ $R_{\rm Gext} = 10 \Omega$	$T_j = 150^{\circ}C$		1.2		111,0
R <sub>Gint</sub>	Internal gate resistance				3		Ω
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.2	°C/W

### Source - Drain diode ratings and characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$V_{SD}$	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 50A$		3.3		V
		$V_{GS} = -2V, I_{SD} = 50A$		3.1		v
t <sub>rr</sub>	Reverse Recovery Time	$I_{SD} = 100A ; V_{GS} = -5V V_R = 800V ; di_F/dt = 2000A/\mu s$		45		ns
Q <sub>rr</sub>	Reverse Recovery Charge			0.8		μC
I <sub>rr</sub>	Reverse Recovery Current			26		А

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### SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					1200	V
т	Description Connect	$V_{R} = 1200 V$	$T_j = 25^{\circ}C$		70	400	
I <sub>RRM</sub>	Reverse Leakage Current	<b>v</b> <sub>R</sub> -1200 <b>v</b>	$T_{j} = 175^{\circ}C$		130	800	μA
I <sub>F</sub>	DC Forward Current		$Tc = 125^{\circ}C$		40		А
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 40 A$	$T_i = 25^{\circ}C$		1.5	1.8	V
• F	Diode Forward Voltage	$I_F = 40A$	$T_i = 175^{\circ}C$		2.2	3	v
Q <sub>C</sub>	Total Capacitive Charge	$I_F = 40A, V_R = di/dt = 1000A/\mu$		260		nC	
С	Total Canacitanaa	$f = 1 MHz, V_R = 400 V$			186		nΕ
	Total Capacitance	$f = 1 MHz, V_R = 800 V$			134		pF
R <sub>thJC</sub>	Junction to Case Thermal Resistance	tion to Case Thermal Resistance				0.55	°C/W

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
$\Delta R_{25}/R_{25}$			5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$		3952		K
$\Delta B/B$	T <sub>C</sub> =100	°C	4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

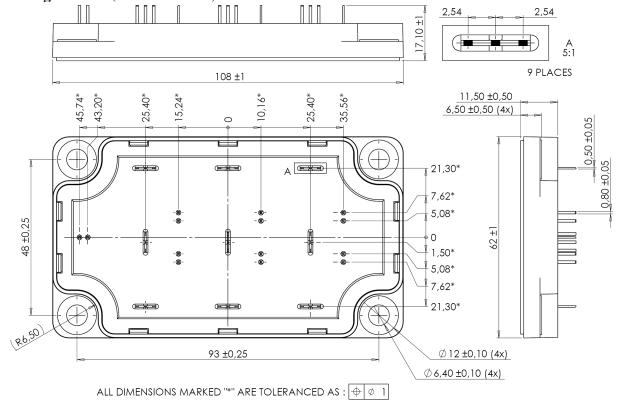
## Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
т	Operating junction temperature range SiC MOSFET SiC diode		SFET	-40	150	
T <sub>J</sub>			ode	-40	175	
T <sub>JOP</sub>	Recommended junction temperature under switching conditions			-40	T <sub>J</sub> max -25	°C
T <sub>STG</sub>	Storage Temperature Range			-40	125	
T <sub>C</sub>	Operating Case Temperature			-40	100	
Torque	Mounting torque	To heatsink	M6	3	5	N.m
Wt	Package Weight				250	g

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Package outline (dimensions in mm)

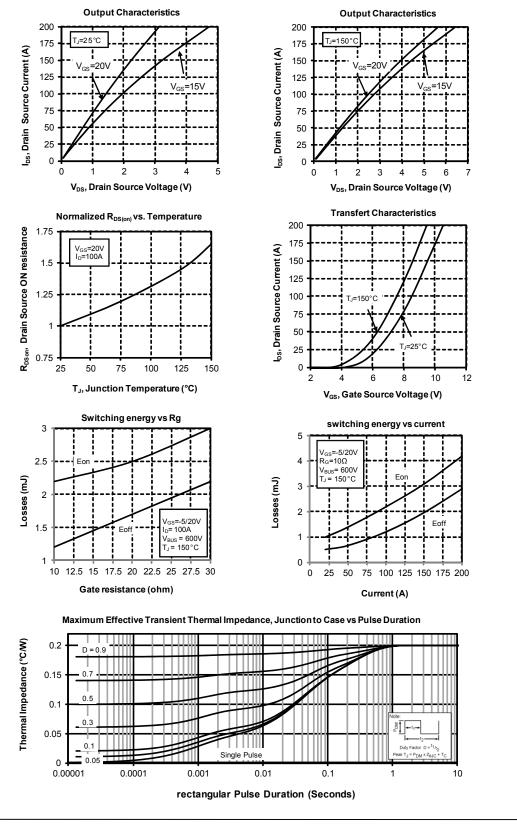


See application note 1902 - Mounting Instructions for SP6-P (12mm) Power Modules on www.microsemi.com

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#### **Typical SiC MOSFET Performance Curve**

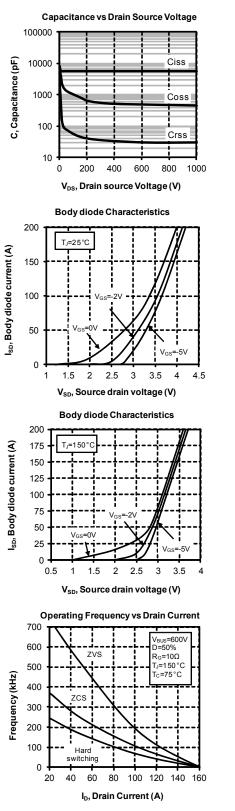


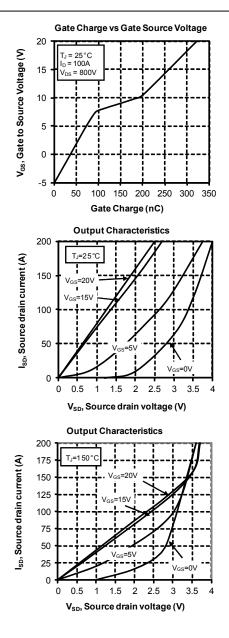
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Typical SiC diode Performance Curve

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